

TECHNICAL REPORT

Effective area measurements of single-mode optical fibres - Guidance

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INTERNATIONAL ELECTROTECHNICAL COMMISSION

Effective area measurements of single-mode optical fibres - Guidance

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IEC TR 62284 has been prepared by subcommittee 86A: Fibres and cables, of IEC technical committee 86: Fibre optics. It is a Technical Report.

This second edition cancels and replaces the first edition published in 2003. This edition constitutes a technical revision.

This edition includes the following significant technical changes with respect to the previous edition:

- a) improvement of the description of measurement details for B-657 fibre;
- b) modification of the minimum distance between the fibre end and the detector for the direct far field scan (Annex A);
- c) deletion of Annex H.

The text of this Technical Report is based on the following documents:

Draft	Report on voting
86A/2619/DTR	86A/2641/RVDTR

Full information on the voting for its approval can be found in the report on voting indicated in the above table.

The language used for the development of this Technical Report is English.

This document was drafted in accordance with ISO/IEC Directives, Part 2, and developed in accordance with ISO/IEC Directives, Part 1 and ISO/IEC Directives, IEC Supplement, available at www.iec.ch/members_experts/refdocs. The main document types developed by IEC are described in greater detail at www.iec.ch/publications.

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